

Tips and tricks on searching IEEE Xplore

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March 2020

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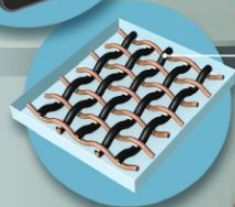
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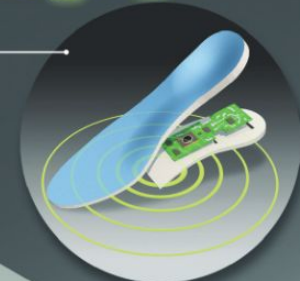


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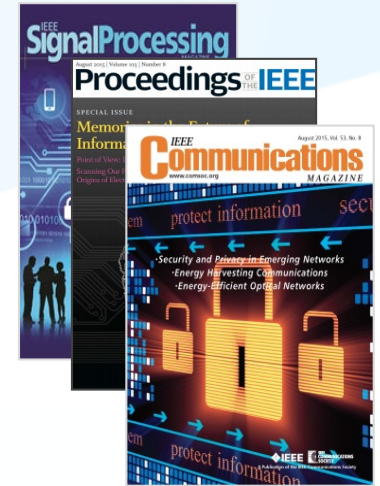


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Code
Ocean

The screenshot shows an IEEE Xplore article page for the paper "When Slepian Meets Fiedler: Putting a Focus on the Graph Spectrum". The article is published in IEEE Signal Processing Letters, Volume 24, Issue 7, July 2017. The authors are Dimitris Van De Walle, Polina Demireva, and Maria Giulia Peled. The abstract discusses the study of complex systems using graph models and the eigendecomposition of the graph Laplacian. A Code Ocean widget is embedded on the page, showing a Jupyter notebook interface with a colorful tiger image and a list of files. The widget includes a "Code" tab and a "Dataset" tab. The article page also features a search bar, navigation links, and a "Need Full-Text" banner.

Code Ocean in IEEE Xplore

- IEEE introduced a new module within IEEE Xplore (in the Code and Datasets Tab) for Code Ocean that allows users to leverage the tools of Code Ocean right in IEEE Xplore (without leaving the site).
- Users can perform key functions within the module such as download files, run algorithms, etc.

The screenshot displays the IEEE Xplore search results page for the paper "Minimum mean brightness error bi-histogram equalization in contrast enhancement". The interface includes a search bar at the top, a filter sidebar on the left, and a main content area. The main content area shows the paper title, authors (Soong-Der Chen; A.R. Ramli), and citation statistics (408 Paper Citations, 2 Patent Citations, 3432 Full Text Views). A red circle highlights the "Code Available" badge in the top right corner of the paper entry. Another red circle highlights the "Code" icon in the bottom right corner of the paper entry. The filter sidebar on the left shows "Showing results 1-4 of 4 for minimum mean brightness error bi-histogram" and includes filters for "Conferences (2)", "Journals & Magazines (2)", "Show" (All Results, Open Access), and "Year" (Single Year, Range).

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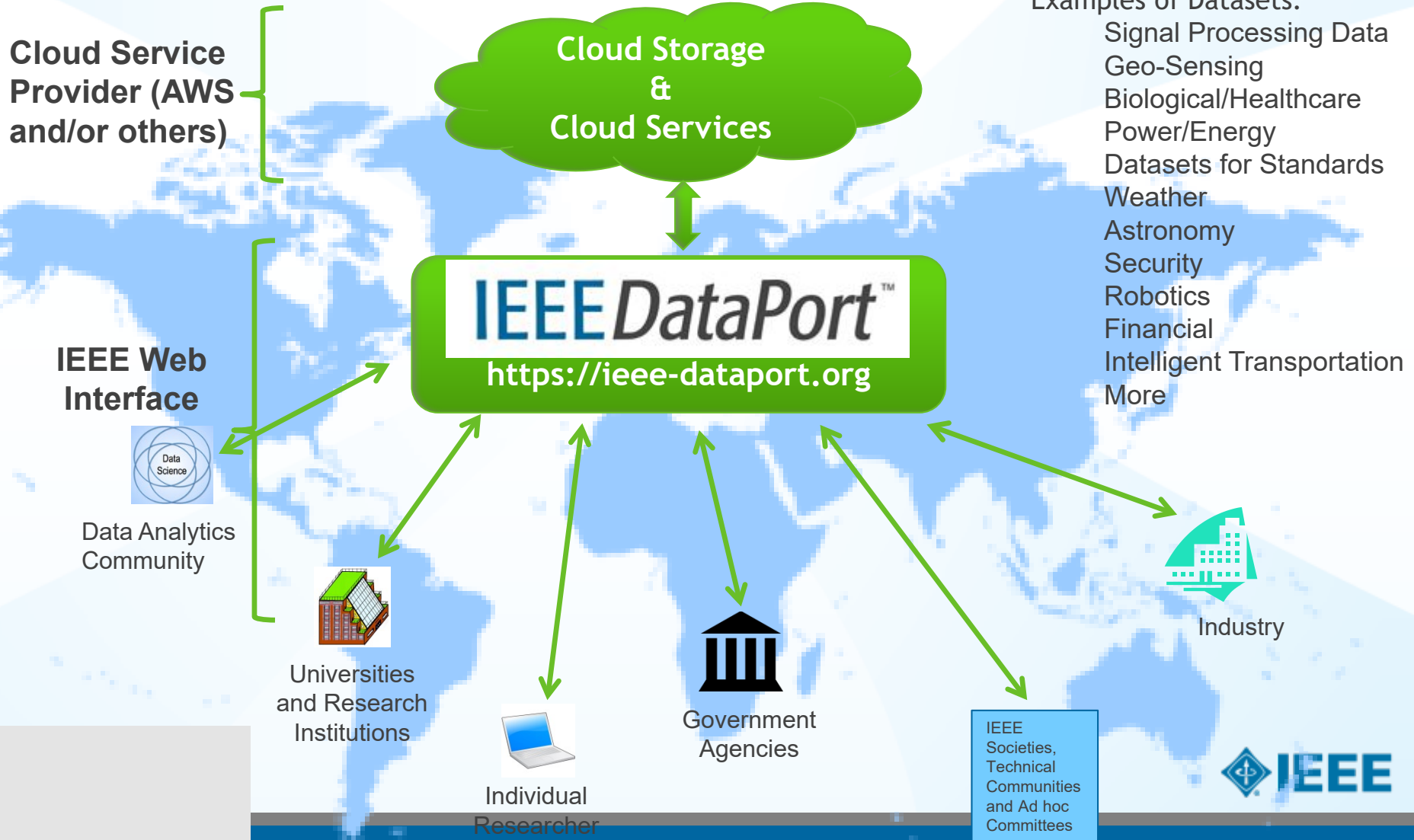
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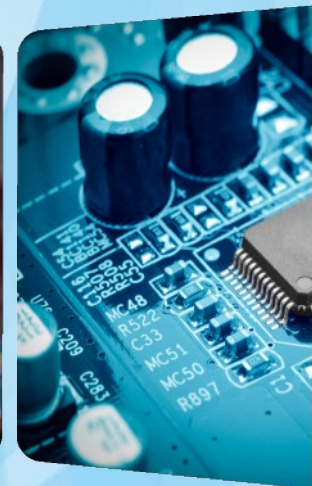
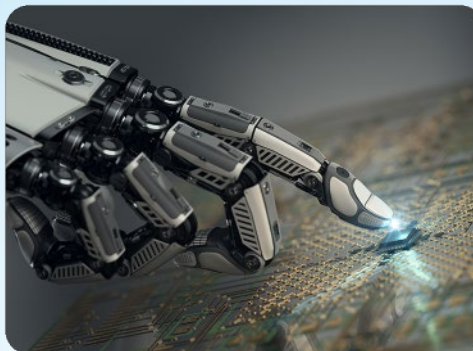
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Boolean Operators (AND/OR/NOT)	Yes	Yes (not within single search box)	Yes
Proximity Operators (NEAR/ONEAR)	Yes	No	Yes
Field Searching	Yes	Yes	Yes

	Character	Description
Wildcards	* ?	<ul style="list-style-type: none"> - Asterisk (*) represents a single character, multiple characters, or no characters - "?" character supported for single Wildcard - Wildcards CAN be used within phrased searches "medical imag*" - Wildcards CAN be used with proximity operators implant* NEAR/5 cardiac
Phrase	"..."	<ul style="list-style-type: none"> - Use ASCII code Double quotes "medical imaging" for an exact phrase - Stemmed terms not included in phrased searches

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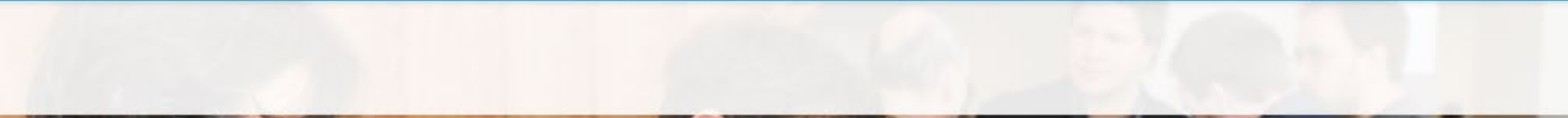
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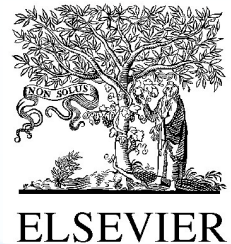
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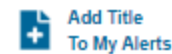
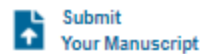
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IEEE Electron Device Letters



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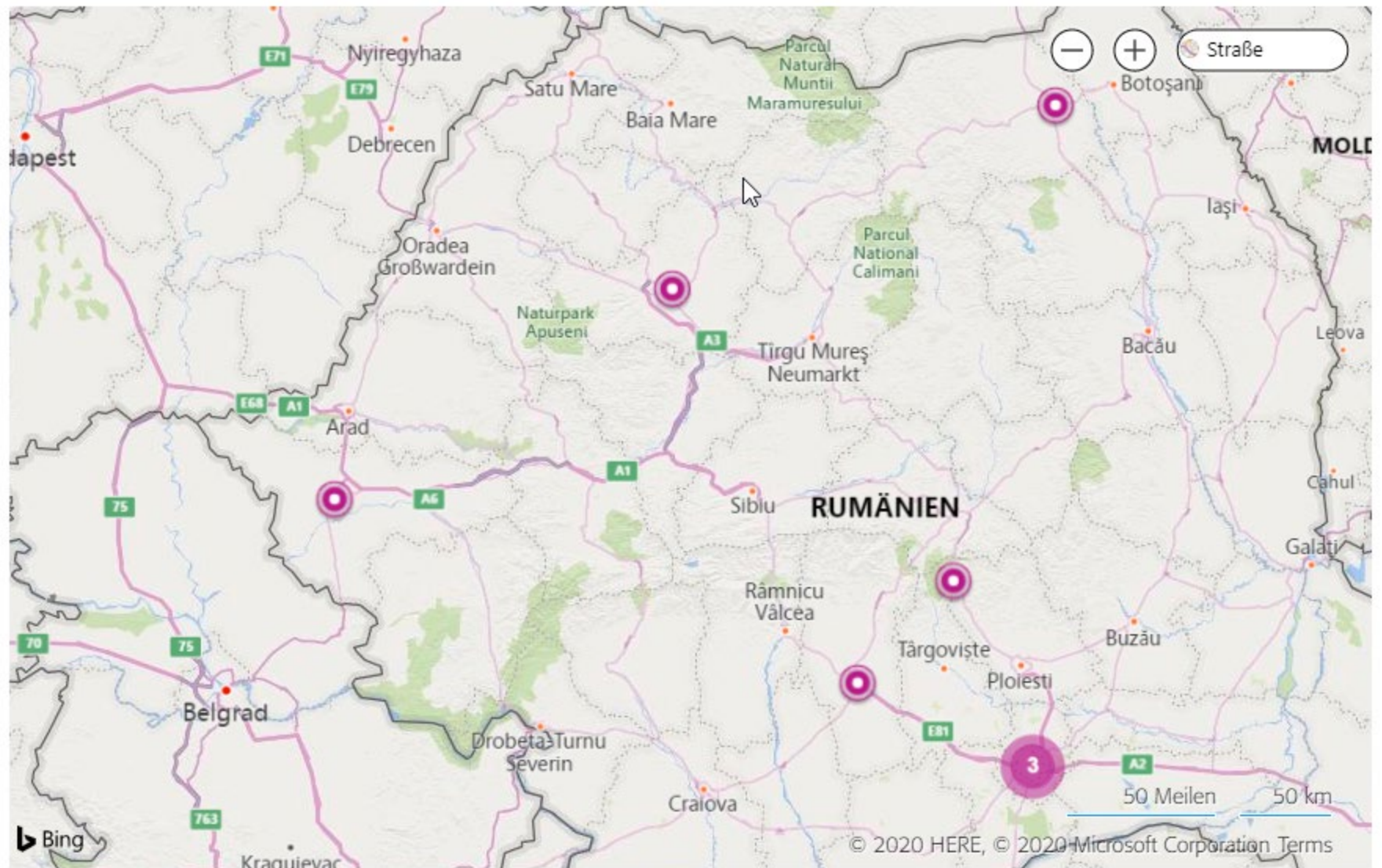
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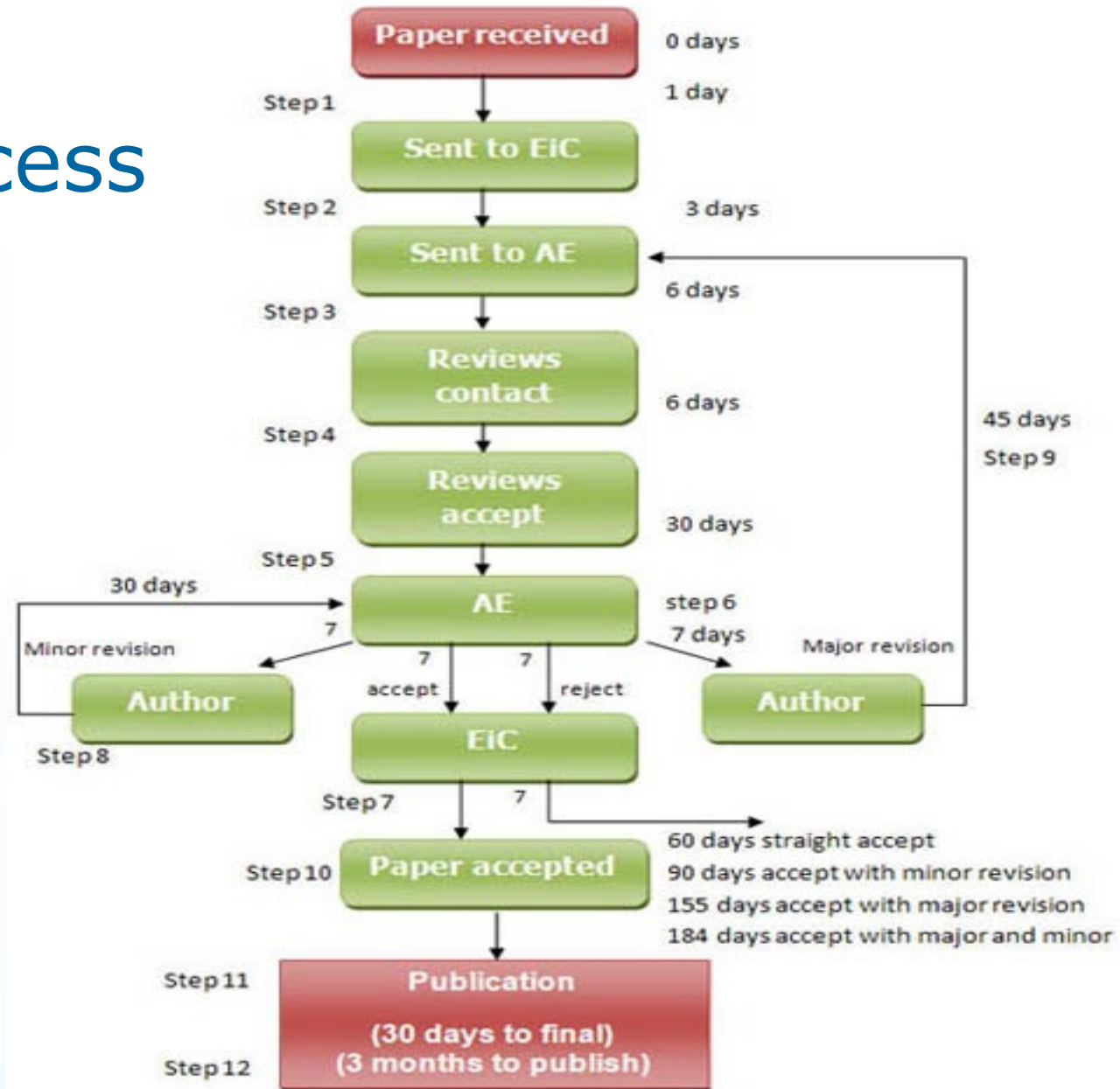
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Manuscript received August 29, 2014; revised November 08, 2014; accepted November 18, 2014. Date of publication December 02, 2014; date of current version April 29, 2015. This work was supported in part by the Natural Sciences and Engineering Research Council (NSERC), in part by the Canada Research Chairs program, and in part by the Ontario Ministry of Research and Innovation. *Asterisk indicates corresponding author.*

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A. Modhafar and M. A. Haider are with Department of Medical Imaging, Sunnybrook Health Sciences Centre, Toronto, ON, M4N 3M5 Canada.

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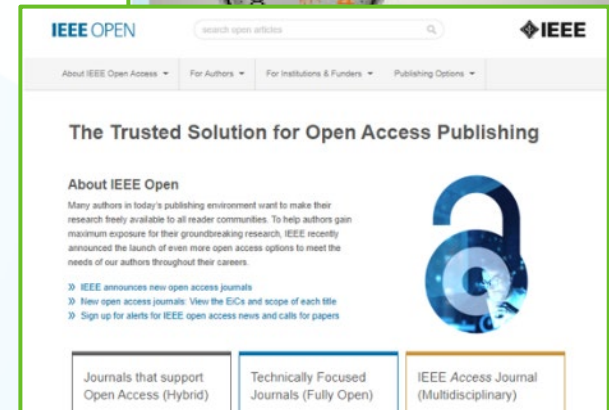
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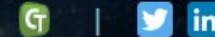
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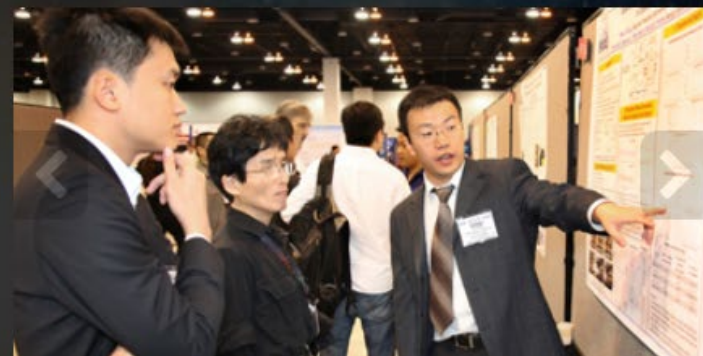


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